



2010 AMERICAN CONTROL CONFERENCE

June 30 – July 2, 2010

Baltimore Marriot Waterfront

Baltimore, Maryland, USA

<http://www.a2c2.org/conferences/acc2010/>

July 2, 2010

General Chair

Glenn Y. Masada
University of Texas at Austin
masada@mail.utexas.edu

Program Chair

Richard D. Braatz
Univ. of Illinois at Urbana-Champaign
braatz@illinois.edu

Vice Chair: Special Sessions

Fahmida Chowdhury
National Science Foundation
fchowdhu@nsf.gov

Vice Chair: Invited Sessions

Frank Allgower
University of Stuttgart
allgower@ist.uni-stuttgart.de

Vice Chair: Industry & Applications

Jeannie Sullivan Falcon
National Instruments
jeannie.falcon@ni.com

Vice Chair: Student Affairs

Douglas A. Lawrence
Ohio University
dal@ohio.edu

Exhibits Chair

Erik A. Johnson
University of Southern California
JohnsonE@usc.edu

Finance Chair

Carolyn Beck
Univ. of Illinois at Urbana-Champaign
beck3@uiuc.edu

Local Arrangements Chair

Richard T. O'Brien
United States Naval Academy
riobrien@usna.edu

Publications Chair

Santosh Devasia
University of Washington
devasia@u.washington.edu

Publicity Chair

May-Win Thein
University of New Hampshire
mthein@cisunix.unh.edu

Registration Chair

Lee H. Keel
Tennessee State University
keel@gauss.tsuniv.edu

Workshops Chair

Michael R. Moan
Raytheon
Intelligence and Infor. Systems Div.
Michael_R_Moan@raytheon.com

Section: FrB21

Title: Performance Analysis of Fault Tolerant Control Systems with I.I.D. Upsets

Authors: Jorge R. Chávez-Fuentes, Oscar R. González, W. Steven Gray

On behalf of the Operating and the Program Committees, it is my pleasure to inform you of your selection as a recipient of the Best Presentation in Session Award at the 2010 American Control Conference (ACC) held at the Baltimore Marriot Waterfront, Baltimore, Maryland, USA, June 30 – July 2, 2010.

The ACC is the annual meeting of American Automatic Control Council (AACC). Held under the auspices of AACC, the US National Member Organization of the International Federation of Automatic Control (IFAC), the ACC brings together people working in control, automation, and related areas from the American Institute of Aeronautics and Astronautics (AIAA), American Institute of Chemical Engineers (AIChE), Association of Iron and Steel Engineers (AISE), American Society of Civil Engineers (ASCE), American Society of Mechanical Engineers (ASME), Institute of Electrical and Electronics Engineers (IEEE), the International Society for Measurement and Control (ISA), and the Society for Computer Simulation (SCS).

Sincerely,

Richard D. Braatz, Ph.D.

Program Chair, ACC 2010